DATA SHEET

I²C BUS

TDA9178
YUV one chip picture improvement based on luminance vector-, colour vector- and spectral processor

Preliminary specification
File under Integrated Circuits, IC02

1999 Sep 24

Philips
Semiconductors

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YUV one chip picture improvement based on luminance vector-, colour vector- and spectral processor
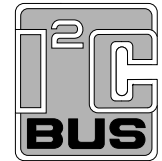
TDA9178

FEATURES

- Picture content dependent non-linear Y, U and V processing by luminance histogram analysis
- Variable gamma control
- Adaptive black and white stretch control
- Skin tone correction
- Green enhancement
- Blue stretch
- Luminance Transient Improvement (LTI)
- Smart peaking for detail enhancement
- Colour Transient Improvement (CTI)
- SCAn VElocity Modulation (SCAVEM) output
- Line Width Control (LWC)
- Video Dependent Coring (VDC)
- Colour Dependent Sharpness (CDS)
- Noise measurement
- Feature Mode (FM) detector
- Cue Flash (CF) detector
- Three additional pins for access to 6-bit ADC and I^{2}C-bus
- Adjustable chrominance delay
- TV standard independent
- I^{2}C-bus controlled
- 1f$_H$ and 2f$_H$
- DEmonstration MOde (DEMO).

GENERAL DESCRIPTION

The TDA9178 is a transparent analog video processor with YUV input and output interfaces. It offers three main functions: luminance vector processing, colour vector processing and spectral processing. Beside these three main functions, there are some additional functions.

In the luminance vector processor, the luminance transfer function is controlled in a non-linear way by the distribution, in 5 discrete histogram sections, of the luminance values measured in a picture. As a result, the contrast ratio of the most important parts of the scene will be improved. Black restoration is available in the event of a set-up in the luminance signal.

A variable gamma function, after the histogram conversion, offers the possibilities of alternative brightness control or factory adjustment of the picture tube.

The adaptive black stretch function of the TDA9178 offers the possibility of having a larger 'weight' for the black parts of the video signal; the white stretch function offers an additional overall gain for increased light production.

To maintain a proper colour reproduction, the saturation of the U- and V-colour difference signals is also controlled as a function of the actual non-linearity in the luminance channel.

In the colour vector processor, the dynamic skin tone correction locally changes the hue of colours that match skin tones to the correct hue. The green enhancement circuit activates medium saturated green towards to more saturated green. The blue stretch circuit can be activated which shifts colours near white towards blue.

The spectral processor provides 1D luminance transient improvement, luminance detail enhancement by smart peaking and a 1 D colour transient improvement.
The TDA9178 can be used as a cost effective alternative to (but also in combination with) scan velocity modulation.

In the spectral processor line width control (or aperture control) can be user defined. The TDA9178 is capable of adjusting the amount of coring according to the video level with the video dependent coring. The TDA9178 is also capable to give extra sharpness in the cases of saturated red and magenta parts of the screen using the colour dependent sharpness feature.

An embedded noise detector measures noise during the field retrace in parts which are expected to be free from video or text information. With the noise detector a variety of 'smart noise control' architectures can be set up.

A feature mode detector is available for detecting signal sources like VCR (in still picture mode) that re-insert the levels of the retrace part. For this kind of signals the noise measurement of the TDA9178 is not reliable.

An output signal (on the I^{2}C-bus and on a separate pin) is available that detects when the picture content has been changed significantly, called cue flash.

An embedded 6-bit ADC can be used for interfacing three analog low frequency voltage signals (e.g. ambient light control or beam current voltage level) to the I^{2}C-bus.

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In the demonstration mode all the features selected by the user are automatically toggled between on and off.

The TDA9178 concept has a maximum flexibility which can be controlled by the embedded I^2C-bus. The supply voltage is 8 V. The device is mounted in a 24-lead SDIP package, or in a 24-lead SO package.

QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V_{CC}	supply voltage		7.2	8.0	8.8	V
$V_{i(Y)}$	luminance input voltage (excluding sync)	AMS = 0	–	0.315	0.45	V
		AMS = 1	–	1.0	1.41	V
$V_{i(UV)}$	UV input voltage		–	–	1.9	V
$V_{FS(ADC)}$	full-scale ADC input voltage		–	2.0	–	V

ORDERING INFORMATION

TYPE NUMBER	PACKAGE		
	NAME	DESCRIPTION	VERSION
TDA9178	SDIP24	plastic shrink dual in-line package; 24 leads (400 mil)	SOT234-1
TDA9178T	SO24	plastic small outline package; 24 leads; body width 7.5 mm	SOT137-1

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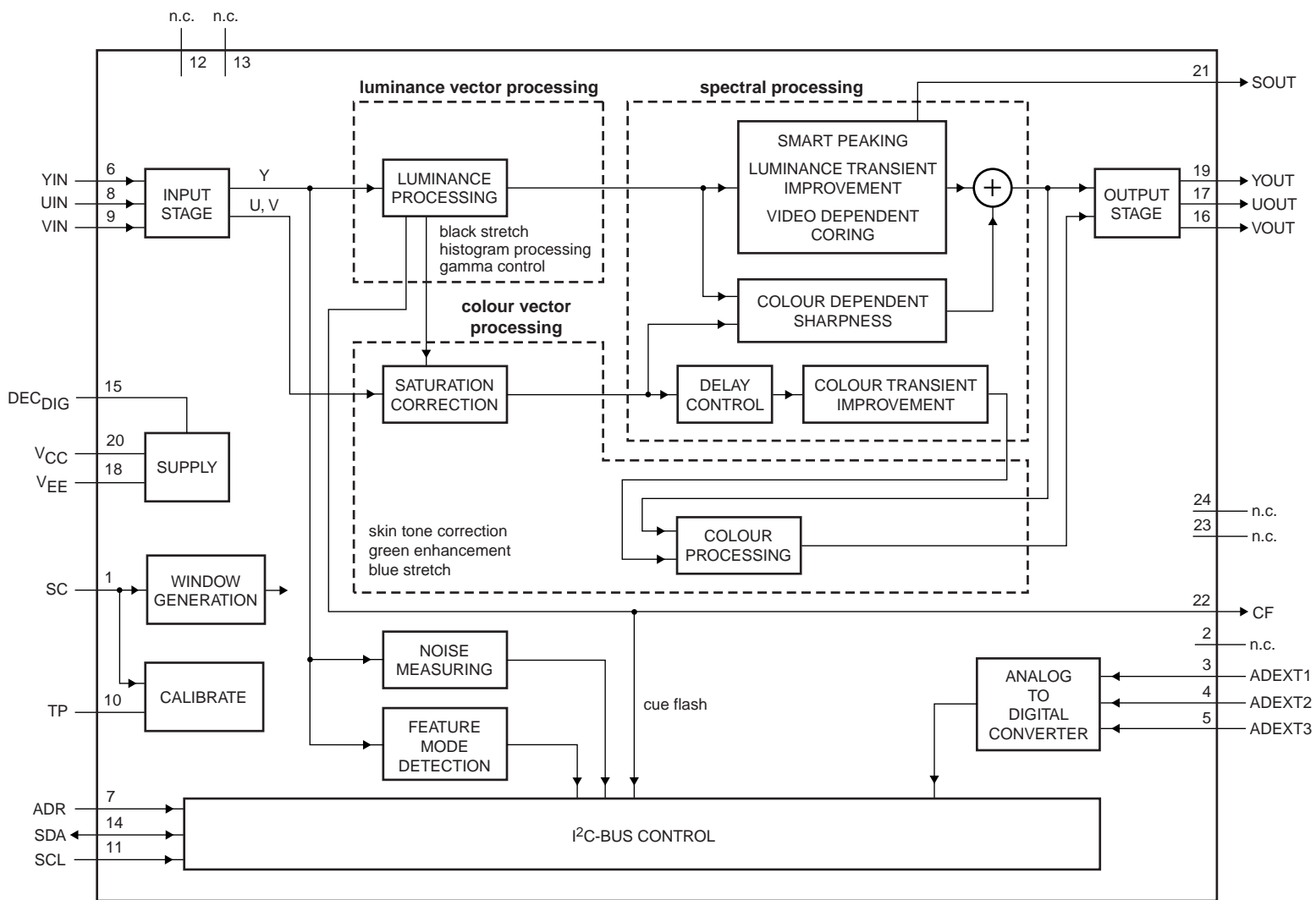
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BLOCK DIAGRAM

Fig.1 Block diagram.

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PINNING

SYMBOL	PIN	DESCRIPTION
SC	1	sandcastle input
n.c.	2	not connected
ADEXT1	3	ADC input 1
ADEXT2	4	ADC input 2
ADEXT3	5	ADC input 3
YIN	6	luminance input
ADR	7	address selection input
UIN	8	U signal input
VIN	9	V signal input
TP	10	test pin
SCL	11	serial clock input (I^{2}C-bus)
n.c.	12	not connected

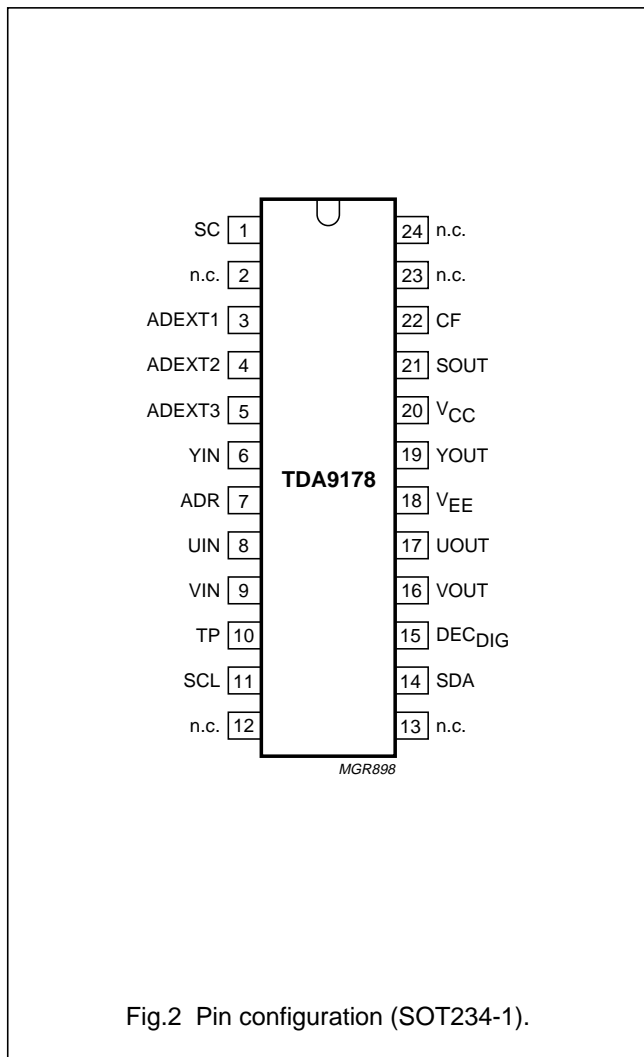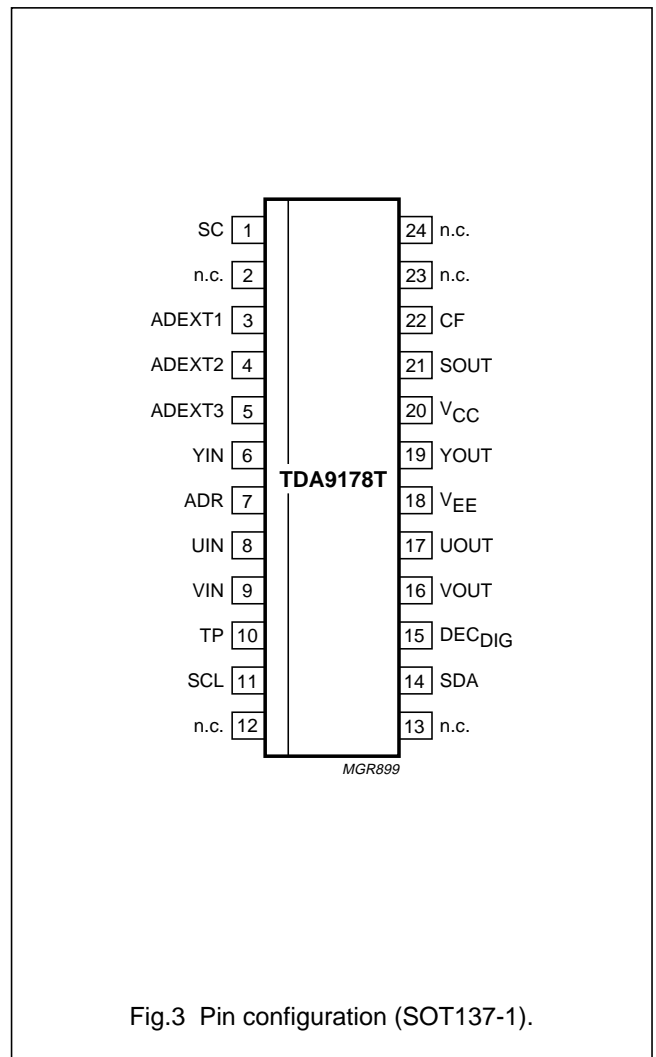| SYMBOL	PIN	DESCRIPTION
n.c.	13	not connected
SDA	14	serial data input/output (I^{2}C-bus)
DEC$_{DIG}$	15	decoupling digital supply
VOUT	16	V signal output
UOUT	17	U signal output
V$_{EE}$	18	ground
YOUT	19	luminance output
V$_{CC}$	20	supply voltage
SOUT	21	SCAVEM output
CF	22	cue flash output
n.c.	23	not connected
n.c.	24	not connected

Fig.2 Pin configuration (SOT234-1).

Fig.3 Pin configuration (SOT137-1).

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FUNCTIONAL DESCRIPTION

Y input selection and amplification

The gain of the luminance input amplifier and output amplifier can be adjusted to signal amplitudes of 0.315 and 1.0 V typically (excluding sync) by I^2C-bus bit AMS. The sync part is processed transparently to the output, independently of the feature settings.
The Y, U and V input signals are clamped during the burstkey period, defined by the sandcastle reference and should be DC-coupled (the circuit uses internal clamp capacitors). During the clamp pulse (see Figs 7, 8, 9 and 10) an artificial black level is inserted in the Y input signal to correctly preset the internal circuitry.

Luminance vector processor

In the luminance vector processor the transfer is controlled by a black stretch, the histogram processing and a gamma control circuit. The luminance vector processor also creates the cue flash signal.

BLACK STRETCH

A black detector measures and stores the level of the most black part of the scene within an internal defined fixed window in each field into a time constant. The time constant and the response time of the loop are internally fixed. Any difference between this value and the value measured during the clamp is regarded as black offset. In a closed loop offsets until a predefined value of the full-scale value are fed back to the input stage for compensation. The loop gain is a function of the histogram and variable gamma settings. The black offset correction can be switched on and off by the I^2C-bus bit BON. Related to the corrected black offset the nominal signal amplitude is set again to 100% full scale through an amplitude stretch function. Luminance values beyond full scale are unaffected. Additionally, the measured black offset is also used to set the adaptive black stretch gain (see also Section "Adaptive black stretch").

HISTOGRAM PROCESSING

For the luminance signal the histogram distribution is measured in real-time over five segments within an internally defined fixed window in each field. During the period that the luminance is in one segment, a corresponding internal capacitor is loaded by a current source. At the end of the field five segment voltages are stored into on-board memories. The voltages stored in the memories determine the non-linear processing of the luminance signal to achieve a picture with a maximum of information (visible details).

Each field the capacitors are discharged and the measurement starts all over again.

Parts in the scene that do not contribute to the information in that scene, like sub or side titles, should be omitted from the histogram measurement. No measurements are performed outside the internal fixed window period.

Very rapid picture changes, also related to the field interlace, can result in flicker effects. The histogram values are averaged at the field rate thus cancelling the flicker effects.

Adaptive black stretch

The so-called adaptive black stretch gain is one of the factors that control the gamma of the picture. This gain is controlled by the measured black offset value in the black stretch circuit and the I^2C-bus adaptive black stretch DAC: bits BT5 to BT0. For pictures with no black offset the black stretch gain equals unity so the gamma is not changed and the DAC setting has no influence. In case of a black offset, the black stretch gain is increased so the gamma of the picture is reduced. This procedure results in a maximum of visible details over the whole range of luminances. However, depending on personal taste, sometimes higher values of gamma are preferred. Therefore the amount of gamma reduction can be adjusted by the DAC.

Adaptive white-point stretching

For pictures with many details in white parts, the histogram conversion procedure makes a transfer with large gain in the white parts. The amount of light coming out of the scene is reduced accordingly. The white stretcher introduces additional overall gain for increased light production, and so violating the principle of having a full-scale reference. The white-point stretching can be switched on or off by means of the I^2C-bus bit WPO.

Standard deviation

For scenes in which segments of the histogram distribution are very dominant with respect to the others, the non-linear amplification should be reduced in comparison to scenes with a flat histogram distribution. The standard deviation detector measures the spread of the histogram distribution and modulates the user setting of the non-linear amplifier.

Non-linear amplifier

The stored segment voltages determine the individual gain of each segment in such a way that continuity is granted for the complete luminance range.

The maximum and minimum gain of each segment is limited. Apart from the adaptive white-point stretching the black and white references are not affected by the non-linear processing. The amount of non-linearity can be controlled by the I^{2}C-bus non-linearity DAC: bits NL5 to NL0.

CUE FLASH

VARIABLE GAMMA

On top of the histogram conversion a variable gamma function is applied for an alternative brightness control, or for factory adjustment. It is intended as an alternative for the DC-offset of the classic brightness user control. It maintains the black and white references. The gamma ranges from 0.5 to 1.5. The gamma can be set by the I^{2}C-bus variable gamma DAC: bits VG5 to VG0.

CUE FLASH

In the present TV environment there is a lot of measured information like ambient light and noise. This information can be used to make an update of settings of the several algorithms after a picture has changed. The cue flash signal detects when a picture changes significantly. When the picture content has changed, the I^{2}C-bus bit CF is set to logic 1 in the status register. After reading the status register, bit CF is reset to logic 0. On the output pin CF the cue flash information is present (active LOW) for only one line in the vertical retrace part. This pin is configured as an open drain output and therefore should be pulled up to the 5 V supply.

Spectral processor

In the spectral processor the luminance transfer is controlled by smart peaking, colour dependent sharpness and luminance transient improvement, defined by the sharpness improvement processor. The colour transfer is controlled by a colour transient improvement circuit; an additional output is available to provide a SCAVEM circuit.

ADJUSTABLE CHROMINANCE DELAY

The colour vector processor drives a delay line for correcting delay errors between the luminance input signal and the chrominance input signals (U and V). The chrominance delay can be adjusted in 6 steps of 12 ns (1f$_H$) or 6 ns (2f$_H$) by the I^{2}C-bus bits CD2 to CD0.

SHARPNESS IMPROVEMENT PROCESSOR

The sharpness improvement processor increases the slope of large luminance transients of vertical objects and enhances transients of details in natural scenes by contour correction.

It comprises three main processing units: the step improvement processor, the contour processor and the smart sharpness controller.

Transient improvement processor

The step improvement processor (see Fig.11) comprises two main functions:

- MINMAX generator
- MINMAX fader.

The MINMAX generator utilizes all taps of an embedded luminance delay line to calculate the minimum and maximum envelope of all signals momentarily stored in the delay line. The MINMAX fader chooses between the minimum and maximum envelopes, depending on the polarity of a decision signal derived from the contour processor. Figures 12, 13 and 14 show some waveforms of the step improvement processor and illustrate that fast transients result with this algorithm. The MINMAX generator also outputs a signal that represents the momentary envelope of the luminance input signal. This envelope information is used by the smart sharpness controller.

Line width control (also called aperture control) can be performed by I^{2}C-bus line width DAC: bits LW5 to LW0. This control can be used to compensate for horizontal geometry errors caused by the gamma, for blooming of the spot of the CRT, or for compensating SCAVEM.

Contour processor

The contour processor comprises two contour generators with different frequency characteristics. The contour generator generates a second-order derivative of the incoming luminance signal which is supplied to the smart sharpness controller. In the smart sharpness controller, this signal is added to the properly delayed original luminance input signal, making up the peaking signal for detail enhancement. The peaking path features a low peaking frequency of 2 MHz (at 1f$_H$), or a high peaking frequency of 3 MHz (at 1f$_H$), selectable by I^{2}C-bus bit CFS.

The contour generators utilize three taps of the embedded luminance delay line. Figure 15 illustrates the normalized frequency transfer of the filter.

Smart sharpness controller

The smart sharpness controller (see Fig.16) is a fader circuit that fades between peaked luminance and step-improved luminance, controlled by the output of a step discriminating device known as the step detector. It also contains a variable coring level stage.

The step detector is basically a differentiator, so both amplitude of the step and its slope add to the detection criterion. The smart sharpness controller has four user controls:

- Steepness control, performed by the I^{2}C-bus DAC: bits SP5 to SP0

- Peaking control, performed by the I^{2}C-bus DAC: bits PK5 to PK0

- Video dependent coring, switched on or switched off by the I^{2}C-bus bit VDC

- Coring level control, performed by the I^{2}C-bus DAC: bits CR5 to CR0.

The steepness setting controls the amount of steepness in the edge-correction processing path.

The peaking setting controls the amount of contour correction for proper detail enhancement. The envelope signal generated by the step improvement processor modulates the peaking setting in order to reduce the amount of peaking for large sine wave excursions.

With video dependent coring, it is possible to have more reduction of the peaking in the black parts of a scene than in the white parts, and therefore automatically reducing the visibility of the background noise.

The coring setting controls the coring level in the peaking path for rejection of high-frequency noise.

All four settings facilitate reduction of the impact of the sharpness features, e.g. for noisy luminance signals.

COLOUR DEPENDENT SHARPNESS

The colour dependent sharpness circuit increases the luminance sharpness in saturated red and magenta parts of the screen. Because of the limited bandwidth of the colour signals, there is no need to increase the high frequencies of the colour signals. Instead, the details in the luminance signal will be enhanced. In this circuit a limited number of colours are enhanced (red and magenta). Contrary to normal peaking algorithm, extra gain is applied for low frequencies (2 MHz at 1f$_H$). This is needed, because the information that is lacking below 2 MHz (at 1f$_H$) is most important. In large coloured parts the normal peaking is still active to enhance the fine details.

The smart peaking algorithm has been designed such that the luminance output amplitude will never exceed 110% of the luminance input signal amplitude. Therefore the normal peaking range (12 dB) will be reduced at large transients, and in case of colour dependent sharpness there is even more reduction.

However, by setting bit OSP (Overrule Smart Peaking) one can undo the extra peaking reduction in case of colour dependant sharpness. It must be emphasized that setting OSP may lead to unwanted large luminance output signals, for instance in details in red coloured objects.

COLOUR TRANSIENT IMPROVEMENT

The colour transient improvement circuit (see Fig.17) increases the slope of the colour transients of vertical objects. Each channel of the CTI circuit basically consists of two delay cells: an electronic potentiometer and an edge detector circuit that controls the wiper position of the potentiometer. Normally the wiper of the potentiometer will be in position B (mid position), so passing the input signal B to the output with a single delay. The control signal is obtained by the signals A and C.

When an edge occurs the value of the control signal will fade between +1 and −1 and finally will become zero again. A control signal value of +1 fades the wiper in position C, passing the two times delayed input signal to the output. A control signal of −1 fades the wiper in position A, so an undelayed input signal is passed to the output. The result is an output signal which has steeper edges than the input signal. Contrary to other existing CTI algorithms, the transients remain time correct with respect to the luminance signal, as the algorithm steepens edges proportionally, without discontinuity.

SCAVEM

A luminance output is available for SCAVEM processing. This luminance signal is not affected by the spectral processing functions.

Colour vector processor

The colour processing part contains skin tone correction, green enhancement and blue stretch. The colour vector processing is dependent on the amplitude and sign of the colour difference signals. Therefore, both the polarity and the nominal amplitude of the colour difference signals are relevant when using the colour vector processor facility.

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SKIN TONE CORRECTION

Skin tones are very sensitive for transmission (hue) errors, because we have an absolute feeling for skin tones.
To make a picture look free of hue error, the goal is to make sure that skin tones are put at a correct colour.

The dynamic skin tone correction circuit achieves this goal by instantaneously and locally changing the hue of those colours which are located in the area in the UV plane that matches skin tones (see Fig.4).

The correction is dependent on luminance, saturation and distance to the preferred axis and can be done towards two different angles. The preferred angle can be chosen by bit ASK in the I²C-bus settings. The settings are 123° (ASK = 0) and 117° (ASK = 1). The enclosed correction area can be increased to 140% with the I²C-bus bit SSK (so-called: Size). The enclosed detection 'angle' of the correcting area can be increased to 160% with the I²C-bus bit WSK (so-called: Width). The skin tone correction can be switched on or off with the I²C-bus bit DSK.

GREEN ENHANCEMENT

The green enhancement circuit (see Fig.5) is intended to shift low saturated green colours towards more saturated green colours. This shift is achieved by instantaneously and locally changing those colours which are located in the area in the UV plane that matches low saturated green. The saturation shift is dependent on the luminance, saturation and distance to the detection axis of 208°. The direction of shift in the colour is fixed by hardware. The amount of green enhancement can be increased to 160% by the I²C-bus bit GGR. The enclosed detection 'angle' of the correcting area can be increased to 160% with the I²C-bus bit WGR (so-called: Width). The enclosed correction area can be increased to 140% with the I²C-bus bit SGR (so-called: Size). The green enhancement can be switched on or switched off with the I²C-bus bit DGR.

BLUE STRETCH

The blue stretch circuit (see Fig.6) is intended to shift colours near white towards more blueish coloured white to give a brighter impression. This shift is achieved by instantaneously and locally changing those colours which are located in the area in the UV plane that matches colours near white. The shift is dependent on the luminance and saturation. The direction of shift (towards an angle of 330°) in the colour is fixed by hardware. The amount of blue stretch can be increased to 160% by the I²C-bus bit GBL.

The enclosed correction area can be increased to 140% by the I²C-bus bit SBL (so-called: Size). The blue stretch can be switched on or off by the I²C-bus bit DBL.

SATURATION CORRECTION

The non-linear luminance processing done by the histogram modification and variable gamma, influences the colour reproduction; mainly the colour saturation. Therefore, the U and V signals are linear processed for saturation compensation.

Noise measuring

A video line which is supposed to be free from video information ('empty line') is used to measure the amount of noise. The measured RMS value of the noise can be used for reducing several features, by the I²C-bus interface, such as luminance vector processing and spectral processing. For the TDA9178 the empty line is chosen three lines after recognition of the vertical blanking from the sandcastle pulse input. Figures 7, 8, 9 and 10 show the measurement locations for different broadcast norms.

The noise detector is capable of measuring the signal-to-noise ratio between −45 and −20 dB. The output scale runs linearly with dB. The noise samples are averaged for over 20 fields to reduce the fluctuations in the measurement process. It is obvious, that for signal sources (like VCR in still picture mode) that re-insert the levels of the retrace part, the measurement is not reliable (see Section "Feature mode detector"). The result of the averaging process will update the contents of the I²C-bus register: bits ND5 to ND0 at a rate of $\frac{1}{32}$ of the field frequency. If a register access conflict occurs, the data of the noise register is made invalid by setting the flag bit DV (Data Valid) to zero.

Feature mode detector

A detector is available for detecting signal sources (like VCR in still picture mode) that re-inserted the levels of the retrace part. For this kind of signals the noise measurement of the TDA9178 is not reliable, but this detector sets bit FM in the ND-register to logic 1.
For normal video signals bit FM is set to logic 0.
This circuit measures transients (like synchronization pulses) on the luminance input during the internal V-pulse. The feature mode detector is setting bit FM to logic 1 when no transients are present during 2 lines in the vertical retrace part over 3 fields (like the synchronization pulses).

Successive approximation ADC

Pins ADEXT1, ADEXT2 and ADEXT3 are connected to a
6-bit successive approximation ADC via a multiplexer.
The multiplexer toggles between the inputs with each field.
At each field flyback, a conversion is started for two of the
three inputs and the result is stored in the corresponding
bus register ADEXT1, ADEXT2 or ADEXT3. The input pin
ADEXT1 is updated every field, while input fields
ADEXT2 and ADEXT3 are updated once in two
consecutive fields (see Figs 7, 8, 9 and 10). Once in
32 fields the ADEXT2 input is not updated, because then
the noise measurement is updated.

In this way, any slow varying analog signal can be given
access to the I²C-bus. If a register access conflict occurs,
the data of that register is made invalid by setting the flag
bit DV (Data Valid) to zero.

Smart noise control

With the help of the internal noise detector and a
user-preferred noise algorithm, the user can make a fully
automatic I²C-bus feature reduction, briefly called 'Smart
Noise Control'.

Demonstration mode

By the I²C-bus bit DEM all the picture improvement
features can be demonstrated in one picture. By setting
bit DEM to logic 1, all the features selected by the user are
active for 5 s in 1f$_H$ mode (in 2f$_H$ mode: 2.5 s), and for
another 5 s in 1f$_H$ mode (in 2f$_H$ mode: 2.5 s) all features
selected are turned off (then the TDA9178 is 'transparent'
to the incoming signal).

Internal window

To determine the histogram levels and the black offset the
TDA9178 performs several measurements. An internally
defined window serves to exclude parts in the scene like
'subtitling' or 'logos'. The internal window can be regarded
as a weighting function which has a value of one within a
square near the centre of the screen and which gradually
decreases to zero towards the edges.

When bit WLB (Window Letter Box) is made logic 1, the
height of the window is reduced by a factor of $\frac{2}{3}$.
This prevents the contribution of the black bars above and
below a 16 : 9 scene to the measurements.

I²C-bus

The I²C-bus is always in standby mode and responds on a
properly addressed command. Bit PDD (Power-Down
Detected) in the status register is set each time an
interruption of the power supply occurs and is reset only by
reading the status register. A 3-bit identification code can
also be read from the status register, which code can be
used to automatically configure the application by
software.

The input control registers can be written sequentially by
the I²C-bus by the embedded automatic subaddress
increment feature or by addressing them directly.
The output control functions cannot be addressed
separately. Reading out the output control functions
always starts at subaddress 00H and all subsequent
words are read out by the automatic subaddress
increment procedure.

The bits in the I²C-bus are preset to logic 0 at power-on
except for bits AMS and VG5: therefore the TDA9178 is in
1.0 V luminance signal range and the variable gamma is
set to 20H (gamma correction 0%).

I²C-BUS SPECIFICATION

The slave address of the IC is given in Table "Slave
address". If pin ADR of the TDA9178 is connected to
ground, the I²C-bus address is 40H; if pin ADR is
connected to pin DEC$_{DIG}$, the I²C-bus address is E0H.
The circuit operates on clock frequencies up to 400 kHz.

Slave address

A6	A5	A4	A3	A2	A1	A0	R/$\overline{W}$
ADR	1	ADR	0	0	0	0	X

Auto-increment mode is available for subaddresses.

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Control functions

FUNCTIONS	TYPE	SUBADDRESS	DATA BYTE							
			D7	**D6**	**D5**	**D4**	**D3**	**D2**	**D1**	**D0**
Inputs										
Control 1	REG	00	DEM	VDC	WLB	FHS	CFS	LDH	0	AMS
Control 2		01	0	0	OSP	WPO	0	CD2	CD1	CD0
Control 3		02	SGR	WGR	GGR	DGR	SSK	WSK	ASK	DSK
Control 4		03	0	0	BON	CTI	CDS	SBL	GBL	DBL
Adaptive black stretch	DAC	04	0	0	BT5	BT4	BT3	BT2	BT1	BT0
Non-linearity amplifier		05	0	0	NL5	NL4	NL3	NL2	NL1	NL0
Variable gamma		06	0	0	VG5	VG4	VG3	VG2	VG1	VG0
Peaking		07	0	0	PK5	PK4	PK3	PK2	PK1	PK0
Steepness		08	0	0	SP5	SP4	SP3	SP2	SP1	SP0
Coring		09	0	0	CR5	CR4	CR3	CR2	CR1	CR0
Line width		0A	0	0	LW5	LW4	LW3	LW2	LW1	LW0
Outputs										
Status	REG	00	X	X	X	CF	ID2	ID1	ID0	PDD
Noise detection		01	FM	DV	ND5	ND4	ND3	ND2	ND1	ND0
ADEXT1 (output)		02	X	DV	AD5	AD4	AD3	AD2	AD1	AD0
ADEXT2 (output)		03	X	DV	AD5	AD4	AD3	AD2	AD1	AD0
ADEXT3 (output)		04	X	DV	AD5	AD4	AD3	AD2	AD1	AD0

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Input signals

Table 1 Amplitude mode selection

AMS	FUNCTION
0	0.315 V luminance (black to white) at YIN
1	1.0 V luminance (black to white) at YIN

Table 2 Luminance determined histogram

LDH	FUNCTION
0	histogram segments fixed
1	histogram segments determined by peak white

Table 3 Contour filter selection

CFS	FUNCTION
0	peaking frequency is 2 MHz at $1f_H$ or 4 MHz at $2f_H$
1	peaking frequency is 3 MHz at $1f_H$ or 6 MHz at $2f_H$

Table 4 Line frequency selection

FHS	FUNCTION
0	$1f_H$
1	$2f_H$

Table 5 Window letterbox format

WLB	FUNCTION
0	normal internal window format
1	'Letterbox' internal window format

Table 6 Video dependent coring on/off

VDC	FUNCTION
0	video dependent coring off
1	video dependent coring on

Table 7 Demonstration mode on/off

DEM	FUNCTION
0	DEMO off
1	DEMO on: auto-toggle selected features on/off (cycle is 10 s at $1f_H$ or 5 s at $2f_H$)

Table 8 Chrominance delay

CD2	CD1	CD0	FUNCTION
0	0	0	40 ns at $1f_H$ or 20 ns at $2f_H$
1	1	1	−32 ns at $1f_H$ or +16 ns at $2f_H$

Table 9 Overrule smart peaking

OSP	FUNCTION
0	smart peaking (maximum peaking reduced if Coxing)
1	overrule smart peaking

Table 10 White-point stretch on/off

WPO	FUNCTION
0	white-point stretch on
1	white-point stretch off

Table 11 Dynamic skin tone on/off

DSK	FUNCTION
0	skin tone off
1	skin tone on

Table 12 Dynamic skin tone angle

ASK	FUNCTION
0	angle correction 123°
1	angle correction 117°

Table 13 Dynamic skin tone width

WSK	FUNCTION
0	default detection angle
1	60% increased detection angle

Table 14 Dynamic skin tone size

SSK	FUNCTION
0	default area
1	40% increased area

Table 15 Green enhancement on/off

DGR	FUNCTION
0	green enhancement off
1	green enhancement on

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Table 16 Green enhancement gain

GGR	FUNCTION
0	default enhancement
1	60% increased gain

Table 17 Green enhancement width

WGR	FUNCTION
0	default detection angle
1	60% increased detection angle

Table 18 Green enhancement size

SGR	FUNCTION
0	default area
1	40% increased area

Table 19 Blue stretch on/off

DBL	FUNCTION
0	blue stretch off
1	blue stretch on

Table 20 Blue stretch gain

GBL	FUNCTION
0	default gain
1	60% increased gain

Table 21 Blue stretch size

SBL	FUNCTION
0	default area
1	40% increased area

Table 22 Colour dependent sharpness on/off

CDS	FUNCTION
0	colour dependent sharpness off
1	colour dependent sharpness on

Table 23 Colour transient improvement on/off

CTI	FUNCTION
0	colour transient improvement off
1	colour transient improvement on

Table 24 Black offset compensation on/off

BON	FUNCTION
0	black offset compensation off
1	black offset compensation on

Table 25 Adaptive black stretch

BT5	BT4	BT3	BT2	BT1	BT0	FUNCTION
0	0	0	0	0	0	0%
1	1	1	1	1	1	100%

Table 26 Non-linearity amplifier

NL5	NL4	NL3	NL2	NL1	NL0	FUNCTION
0	0	0	0	0	0	0%
1	1	1	1	1	1	100%

Table 27 Variable gamma

VG5	VG4	VG3	VG2	VG1	VG0	FUNCTION
0	0	0	0	0	0	−100%
1	1	1	1	1	1	100%

Table 28 Peaking amplitude

PK5	PK4	PK3	PK2	PK1	PK0	FUNCTION
0	0	0	0	0	0	0%
1	1	1	1	1	1	100%

Table 29 Steepness correction

SP5	SP4	SP3	SP2	SP1	SP0	FUNCTION
0	0	0	0	0	0	0%
1	1	1	1	1	1	100%

Table 30 Coring level

CR5	CR4	CR3	CR2	CR1	CR0	FUNCTION
0	0	0	0	0	0	0%
1	1	1	1	1	1	30%

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Table 31 Line width correction

LW5	LW4	LW3	LW2	LW1	LW0	FUNCTION
0	0	0	0	0	0	33% duty factor at 2 MHz sine wave/1f_H
1	1	1	1	1	1	67% duty factor at 2 MHz sine wave/1f_H

Output signals

Table 32 Power-down detection

PDD	FUNCTION
0	no power-down detected since last read
1	power-down detected

Table 33 Identification code

ID2	ID1	ID0	FUNCTION
0	1	0	TDA9178/N1

Table 34 Cue flash

CF	FUNCTION
0	no cue flash since last read
1	cue flash detected

Table 35 Noise detector

ND5	ND4	ND3	ND2	ND1	ND0	FUNCTION
0	0	0	0	0	0	−45 dB
1	1	1	1	1	1	−20 dB

Table 36 ADEXT1, ADEXT2 and ADEXT3

AD5	AD4	AD3	AD2	AD1	AD0	FUNCTION
0	0	0	0	0	0	external voltage = 0 V
1	1	1	1	1	1	external voltage = 2 V

Table 37 Data valid bit of noise detector/ADEXT1, 2 and 3 registers

DV	FUNCTION
0	data not valid because of possible register access collision
1	data is valid

Table 38 Feature mode detector

FM	FUNCTION
0	normal video signal detected
1	feature mode detected (noise detector is not reliable)

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134); all voltages referenced to ground.

SYMBOL	PARAMETER	MIN.	MAX.	UNIT
V_{CC}	supply voltage	−0.5	+8.8	V
V_n	voltage on any pin	−0.5	V_{CC} + 0.5	V
T_{stg}	storage temperature	−55	+150	°C
T_{amb}	operating ambient temperature	−10	+70	°C
T_j	operating junction temperature	−	150	°C

HANDLING

All pins are protected against ESD by means of internal clamping diodes. The protection circuit meets the following specification:

Human body model: C = 100 pF; R = 1.5 kΩ; all pins >3000 V

Machine model: C = 200 pF; R = 0 Ω; all pins >200 V.

At an ambient temperature of 90 °C, all pins meet the following specification:

$I_{trigger}$ > 100 mA or V_{pin} > 1.5$V_{CC(max)}$

$I_{trigger}$ < −100 mA or V_{pin} < −0.5$V_{CC(max)}$

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT

$R_{th(j\text{-}a)}$	thermal resistance from junction to ambient
	    TDA9178 (SDIP24)
	    TDA9178T (SO24)
		in free air	
			56
			65
				
				K/W
				K/W

QUALITY SPECIFICATION

In accordance with *"SNW-FQ-611 part E"*.

CHARACTERISTICS

V_{CC} = 8 V; T_{amb} = 25 °C; unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
Supply						
SUPPLY VOLTAGE (PIN V_{CC})						
V_{CC}	supply voltage		7.2	8.0	8.8	V
I_{CC}	supply current	$1f_H$ mode	–	100	–	mA
		$2f_H$ mode	–	105	–	mA
DIGITAL SUPPLY DECOUPLING (PIN DEC_{DIG})						
V_{DECDIG}	decoupling voltage		–	5	–	V
I_{DECDIG}	decoupling load current		–	–	1	mA
Input and output selection						
LUMINANCE INPUT (PIN YIN)						
$V_{i(Y)}$	input voltage (excluding sync)	AMS = 0	–	0.315	0.45	V
		AMS = 1	–	1.0	1.41	V
$I_{i(bias)(Y)}$	input bias current	no clamp	–	–	0.1	μA
LUMINANCE OUTPUT (PIN YOUT)						
$V_{o(cl)}$	output voltage level during clamping	AMS = 1	–	2.7	–	V
		AMS = 0	–	0.8	–	V
$G_{Y(i\text{-}o)}$	luminance gain input to output	transparent at AMS = 1; at 1 V (p-p)	0.93	1.04	1.15	
		transparent at AMS = 0; at 0.3 V (p-p)	0.96	1.07	1.18	
S/N(Y)	signal-to-noise ratio of luminance output	transparent	52	–	–	dB
B_Y	luminance bandwidth	$1f_H$ mode (−1 dB); transparent	5	–	–	MHz
		$2f_H$ mode (−1 dB); transparent	6	–	–	MHz
E_{bl}	black level error	transparent	−1.0	0	+1.0	%

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SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
R_o	output resistance		–	–	150	Ω
$I_{o(bias)}$	output bias current		1.3	–	–	mA
C_L	load capacitance		–	–	15	pF
COLOUR DIFFERENCE INPUTS U AND V (PINS UIN AND VIN)						
$V_{i(U)(p\text{-}p)}$	input voltage U (peak-to-peak value)		–	1.33	1.9	V
$V_{i(V)(p\text{-}p)}$	input voltage V (peak-to-peak value)		–	1.05	1.9	V
$I_{i(bias)}$	input bias current	no clamp	–	–	0.1	μA
COLOUR DIFFERENCE OUTPUTS U AND V (PINS UOUT AND VOUT)						
$V_{o(cl)}$	output voltage level during clamping		–	2.7	–	V
$G_{UV(i\text{-}o)}$	gain inputs to output	transparent	0.90	1.00	1.10	
E_{offset}	offset error	transparent	–1	0	+1	%
ΔG_{track}	UV gain tracking error	transparent	–	–	5	%
B_{UV}	bandwidth	$1f_H$ mode; transparent (–3 dB)	2.5	–	–	MHz
		$2f_H$ mode; transparent (–3 dB)	5	–	–	MHz
R_o	output resistance		–	–	150	Ω
$I_{o(bias)}$	output bias current		1.3	–	–	mA
C_L	load capacitance		–	–	15	pF
Luminance vector processing						
BLACK STRETCH						
$BLOS_{cor(i)}$	input black offset correction		8	10	12	%
HISTOGRAM						
White-point stretch						
$G_{WP(max)}$	maximum luminance gain for white stretch	maximum non-linearity setting gain	–	1.1	–	
Non-linear amplifier						
$G_{nla(min)}$	minimum segment gain	maximum non-linearity setting gain	–	0.4	–	
$G_{nla(max)}$	maximum segment gain	maximum non-linearity setting gain	–	2.0	–	
G_{nla}	non-linear control curve	63 steps	–	0 to 100	–	%
VARIABLE GAMMA						
$G_{g(var)(min)L}$	minimum variable gamma setting		–	0.5	–	
$G_{g(var)(max)}$	maximum variable gamma setting		–	1.5	–	
G_{nla}	non-linear control curve	63 steps	–	0 to 100	–	%

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SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
Colour vector processing						
SKIN TONE; note 1 and Fig.4						
φ_{cor}	correction angle	ASK = 0; DSK = 1	–	123	–	deg
		ASK = 1; DSK = 1	–	117	–	deg
φ_{ap}	correction range (or aperture angle)	DSK = 1; SSK = 1; WSK = 0	–	45	–	deg
GREEN ENHANCEMENT; note 1 and Fig.5						
φ_{cor}	correction angle	DGR = 1	–	208	–	deg
φ_{ap}	correction range (or aperture angle)	DGR = 1; SGR = 0; WGR = 0	–	45	–	deg
BLUE STRETCH; note 2 and Fig.6						
$\varphi_{(str)}$	stretch angle	DBL = 1	–	330	–	deg
Spectral processing						
GENERAL						
Q_{max}	maximum contour amplitude at centre frequency	note 3	–	12	–	dB
Contour filter low frequency peaking						
$f_{pc(l)}$	peaking centre frequency	$1f_H$ mode; CFS = 0	–	2.0	–	MHz
		$2f_H$ mode; CFS = 0	–	4.0	–	MHz
Contour filter high frequency peaking						
$f_{pc(h)}$	peaking centre frequency	$1f_H$ mode; CFS = 1	–	3.0	–	MHz
		$2f_H$ mode; CFS = 1	–	6.0	–	MHz
Step detector						
f_{dc}	detection centre frequency	$1f_H$ mode	–	1.18	–	MHz
		$2f_H$ mode	–	2.36	–	MHz
PEAKING						
G_{PK}	peaking control curve	63 steps	–	0 to 100	–	%
CORING						
G_{CR}	coring control curve	63 steps	–	0 to 45	–	%
LUMINANCE TRANSIENT IMPROVEMENT						
$t_{r(min)}$	minimum rise time 10% to 90%	note 4	–	30	–	ns
G_{SP}	steepness control curve	63 steps	–	0 to 100	–	%
Line width control						
$t_{sd(max)}$	maximum step displacement	$1f_H$ mode	–	140	–	ns
		$2f_H$ mode	–	70	–	ns
G_{LW}	line width control curve (duty factor)	63 steps at 1 MHz sine wave at $1f_H$	–	33 to 67	–	%

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
COLOUR TRANSIENT IMPROVEMENT						
$t_{r(min)}$	minimum rise time 10% to 90%	note 5	–	50	–	ns
COLOUR DEPENDENT SHARPNESS						
f_{pc}	peaking centre frequency	$1f_H$ mode	–	2.0	–	MHz
		$2f_H$ mode	–	4.0	–	MHz
Q_{max}	maximum contour amplitude at centre frequency	note 3	–	6	–	dB
SCAVEM						
SCAVEM OUTPUT (PIN SOUT)						
$V_{o(cl)}$	output voltage level during clamping		–	2.2	–	V
G_Y	gain luminance input to SCAVEM output		0.93	1.04	1.15	
B_Y	bandwidth	$1f_H$ mode (−1 dB)	5	–	–	MHz
		$2f_H$ mode (−1 dB)	6.0	–	–	MHz
R_o	output resistance		–	–	150	Ω
$I_{o(bias)}$	output bias current		0.8	–	–	mA
C_L	load capacitance		–	–	15	pF
$t_{d(SOUT-YOUT)}$	delay w.r.t. YOUT		–	−20	–	ns
Successive approximation ADC						
ADC INPUTS (PINS ADEXT1, ADEXT2 AND ADEXT3)						
V_{FS}	full-scale input voltage range	with respect to ground	–	2.0	–	V
$I_{i(bias)}$	input bias current		–	–	0.1	μA
RES	data path resolution		–	6	–	bit
DLE	differential linearity error		–	–	1	LSB
ILE	integral linearity error		–	–	1	LSB
f_{con}	conversion frequency	ADEXT1	–	$1f_V$	–	Hz
		ADEXT2; ADEXT3	–	$0.5f_V$	–	Hz
Q_{adt}	conversion time (video lines)	each channel	–	8	–	lines
Timing						
SANDCASTLE INPUT (PIN SC)						
$I_{i(bias)}$	input bias current		–	–	1	μA
$V_{sc(bn)}$	detection level for blank	no clamping	0.9	1.15	1.40	V
$V_{sc(bc)}$	detection level for clamp		–	$0.9V_{top}$	–	V
$t_{W(bk)}$	burst key pulse width	$1f_H$ mode	1.8	–	–	μs
		$2f_H$ mode	0.9	–	–	μs
t_V	vertical retrace time		6	–	–	lines
$V_{bk(var)(p-p)}$	ripple on sandcastle burst key level (peak-to-peak value)		–	–	$0.04V_{top}$	V

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SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
Overall output group delay performance						
$t_{d(YUV)}$	input to output delay of YUV signals	$1f_H$ mode; transparent	–	300	–	ns
		$2f_H$ mode; transparent	–	180	–	ns
$t_{dm(UV-Y)}$	adjustment delay U and V signals w.r.t. Y signal	$1f_H$ mode; transparent	–32	0	+40	ns
		$2f_H$ mode; transparent	–16	0	+20	ns
Noise measurement						
R_{noise}	range of noise detector	see Figure 18	–45	–	–20	dB
t_{con}	conversion time		–	$32f_V$	–	s
Cue flash						
CUE FLASH OUTPUT (PIN CF); OPEN COLLECTOR						
$V_{o(max)}$	maximum output voltage	pull-up to external supply	–	–	5.5	V
$I_{sink(max)}$	maximum sink current		–	–	1	mA

Notes

1. The amount of correction depends on the parameters of the incoming YUV signals; therefore it is not possible to give exact figures for the correction angle. The aperture angle of the correction range of 45° (±22.5°) is just given as an indication and is valid for an input signal with a luminance signal amplitude of 75% and a colour saturation of 50%.

2. The amount of correction depends on the parameters of the incoming YUV signals; therefore it is not possible to give exact figures for the correction angle.

3. The contour signal cannot be measured separately from the luminance input signal. The contour signal is also processed by the smart noise controller. The frequency transfer in the peaking mode of the luminance signal can be derived from the frequency transfer of the selected contour signal, taking into account the summation of the contour signal and the luminance input signal. The frequency transfer is most easily measured by sine excitation with a relatively small signal amplitude of 10% of the selected dynamic range of the luminance input, to avoid interaction with the step detector.

4. Peaking set to minimum. Input signal is a sine wave with the nominal peak-to-peak amplitude corresponding to the selected input range.

5. Input signal is a 250 kHz block with a rise time of 260 ns and a nominal peak-to-peak amplitude corresponding to the selected input range.
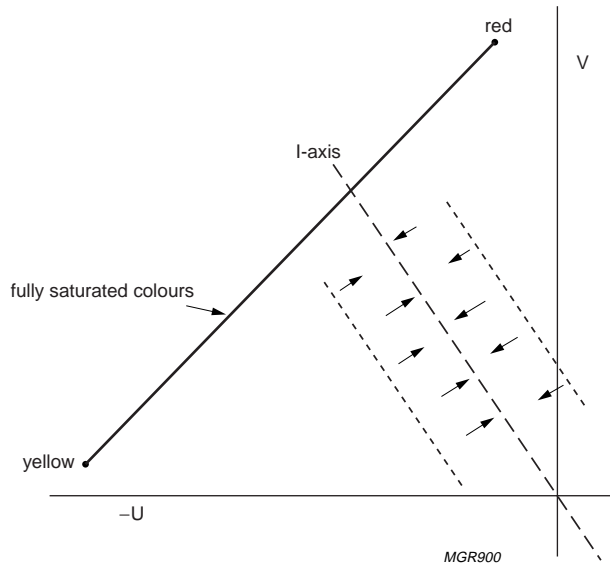
Fig.4 Skin tone correction range for a correction angle of 123°.
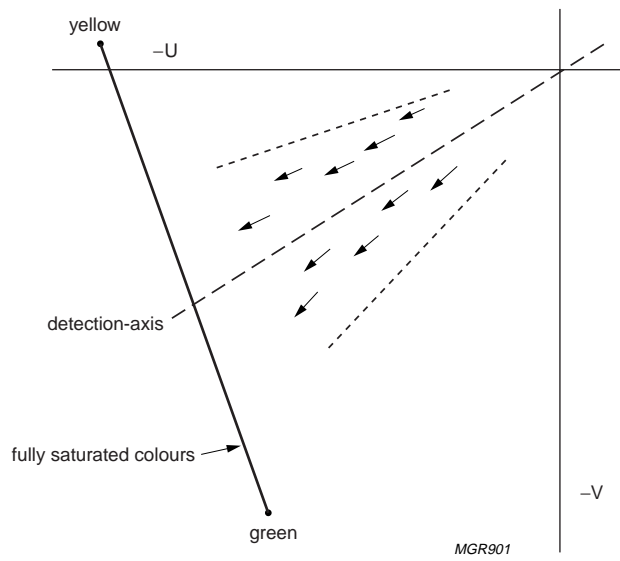
Fig.5 Green enhancement correction range.

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Fig.6 Blue stretch correction range.
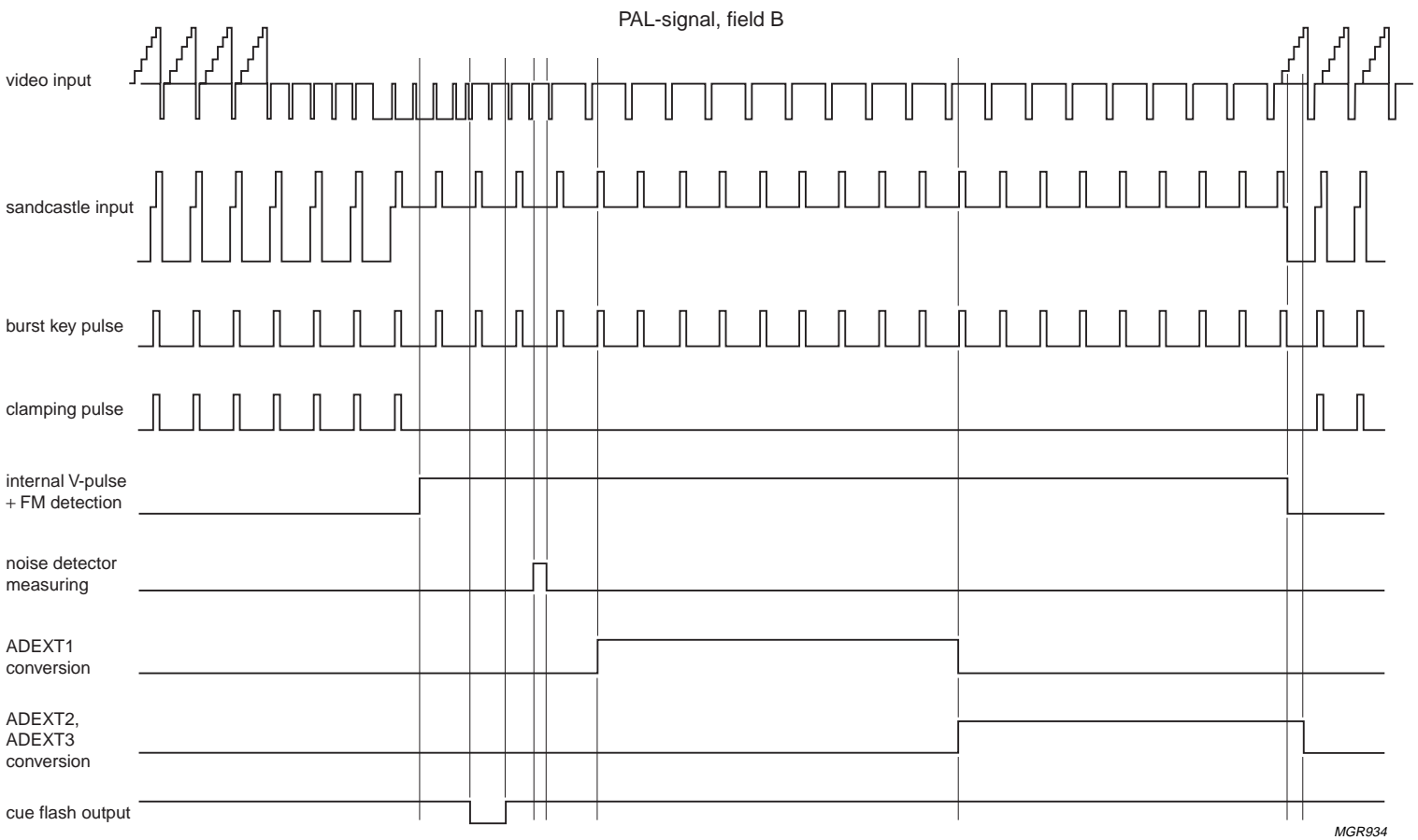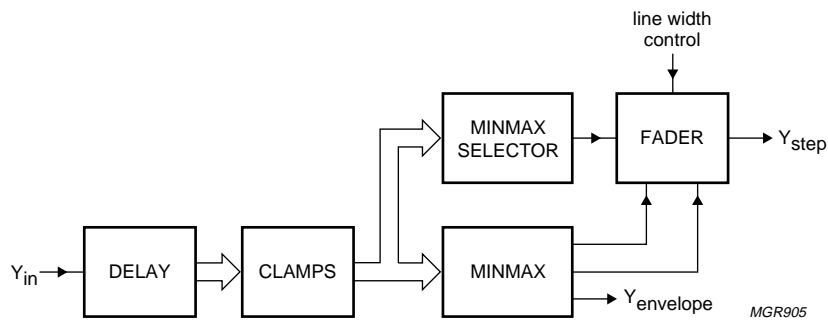
NTSC-signal, field A

video input

sandcastle input

burst key pulse

clamping pulse

internal V-pulse
+ FM detection

noise detector
measuring

ADEXT1
conversion

ADEXT2,
ADEXT3
conversion

cue flash output

MGR903
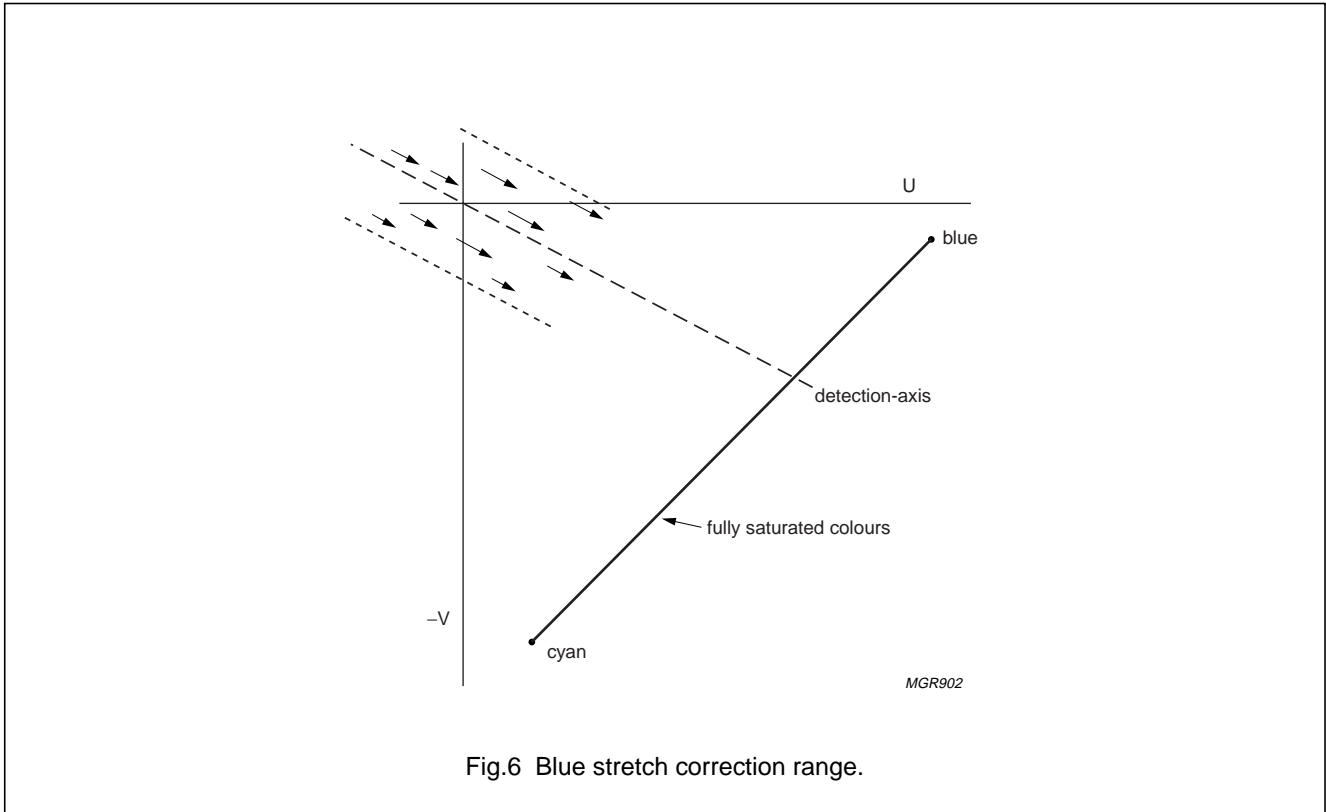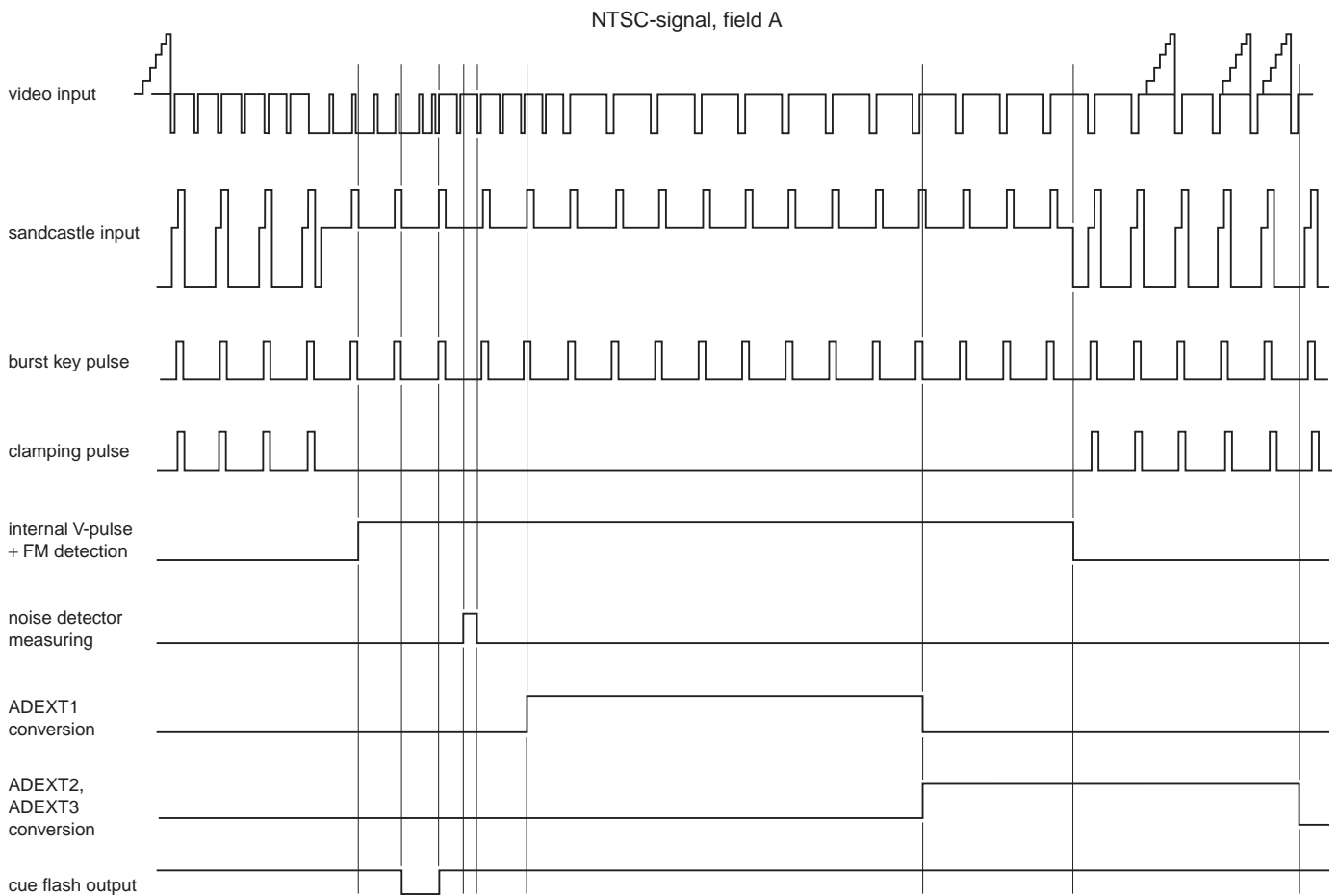
Fig.7 Timing pulses for NTSC input signal, field A.

NTSC-signal, field B

video input

sandcastle input

burst key pulse

clamping pulse

internal V-pulse
+ FM detection

noise detector
measuring

ADEXT1
conversion

ADEXT2,
ADEXT3
conversion

cue flash output

MGR904
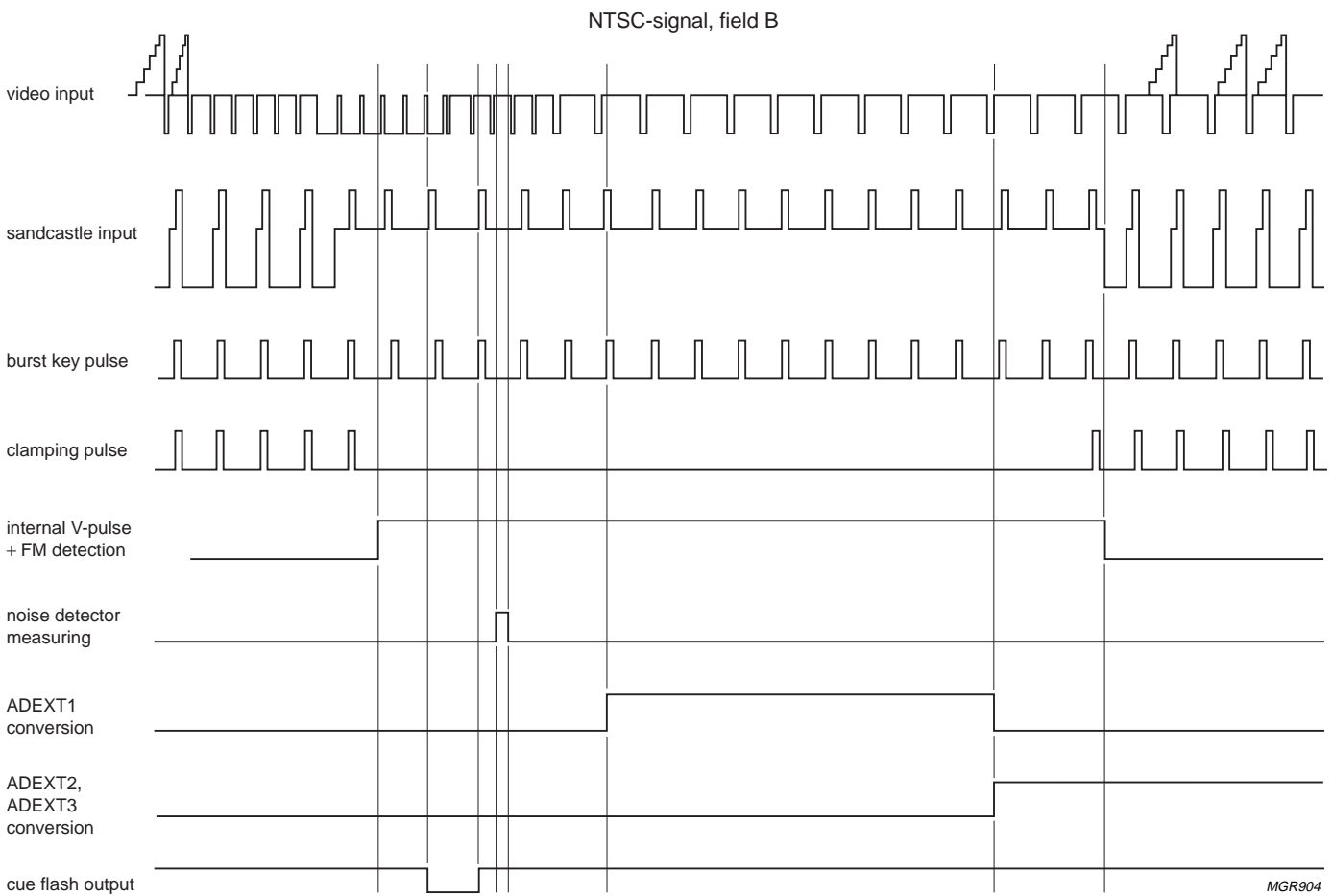
Fig.8 Timing pulses for NTSC input signal, field B.
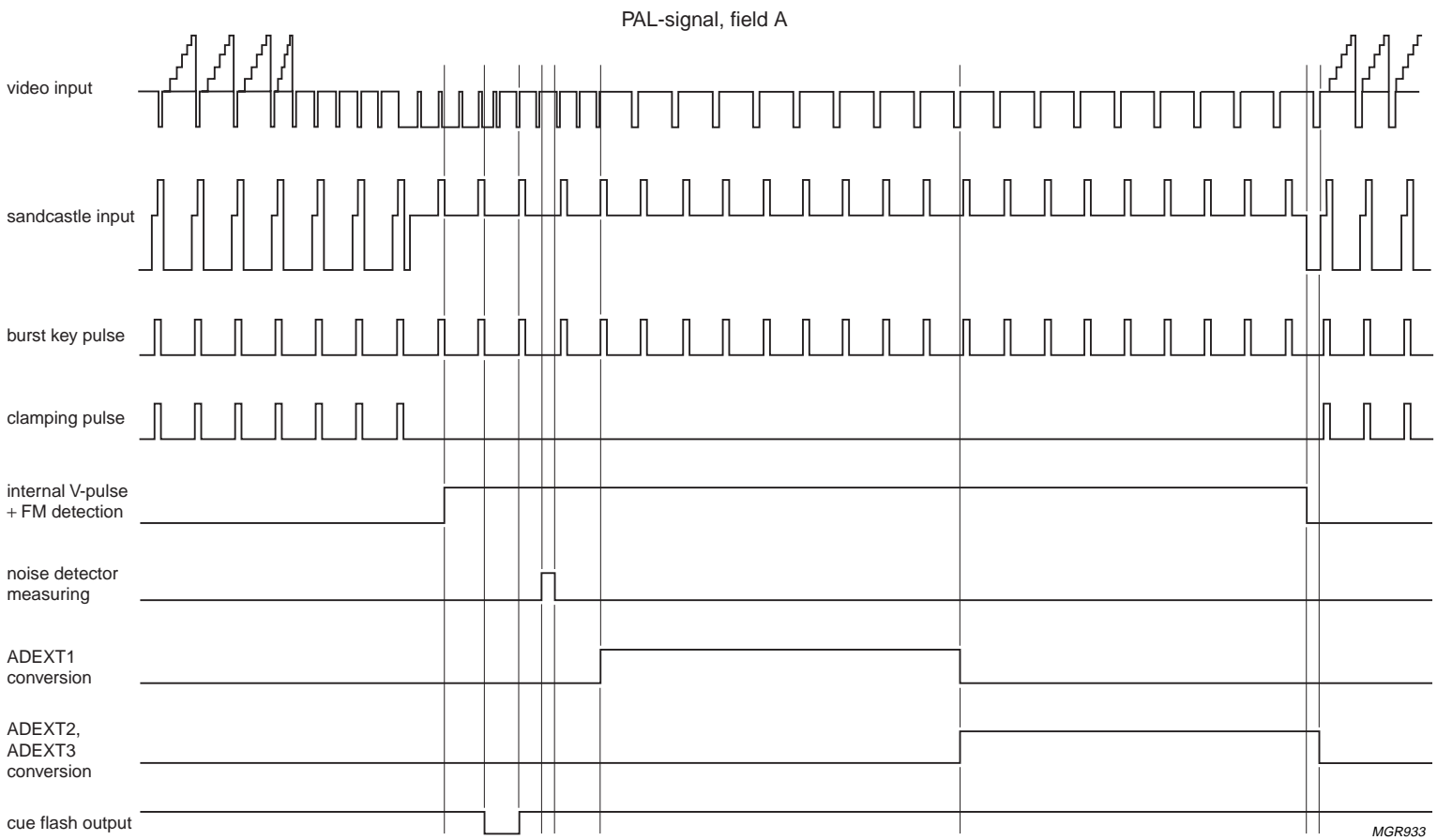
Fig.9 Timing pulses for PAL and SECAM input signal, field A.

PAL-signal, field B

video input

sandcastle input

burst key pulse

clamping pulse

internal V-pulse
+ FM detection

noise detector
measuring

ADEXT1
conversion

ADEXT2,
ADEXT3
conversion

cue flash output

MGR934

Fig.10 Timing pulses for PAL and SECAM input signal, field B.

Fig.11 Block diagram of the step improvement processor.
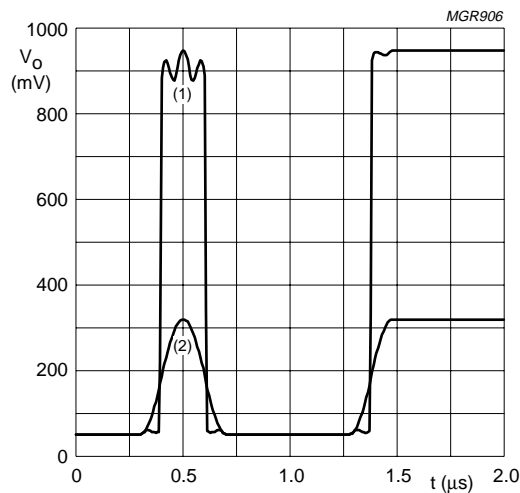
(1) 90% of nominal amplitude.

(2) 30% of nominal amplitude.

Fig.12 Response signals for maximum step improvement, no peaking and nominal line width.

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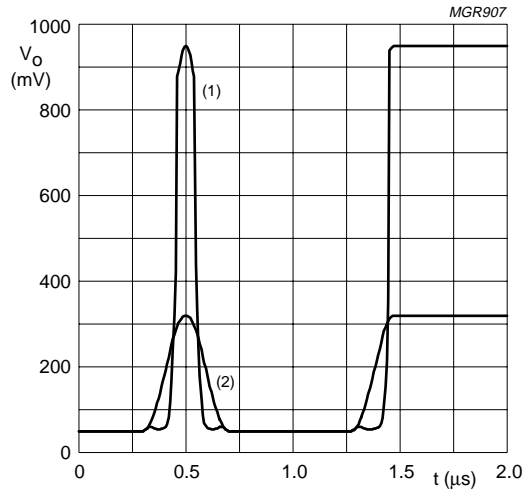
(1) 90% of nominal amplitude.
(2) 30% of nominal amplitude.

Fig.13 Response signals for maximum step improvement, no peaking and minimum line width.
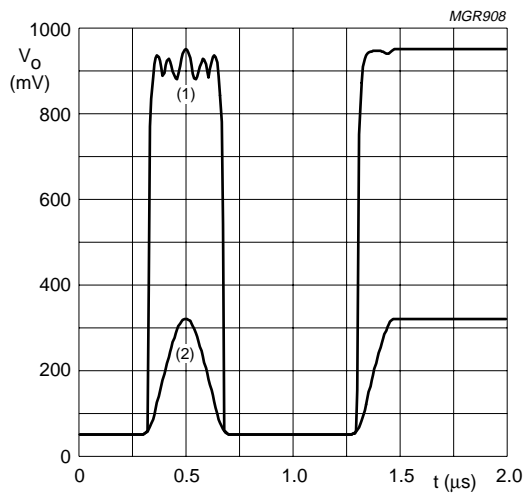
(1) 90% of nominal amplitude.
(2) 30% of nominal amplitude.

Fig.14 Response signals for maximum step improvement, no peaking and maximum line width.
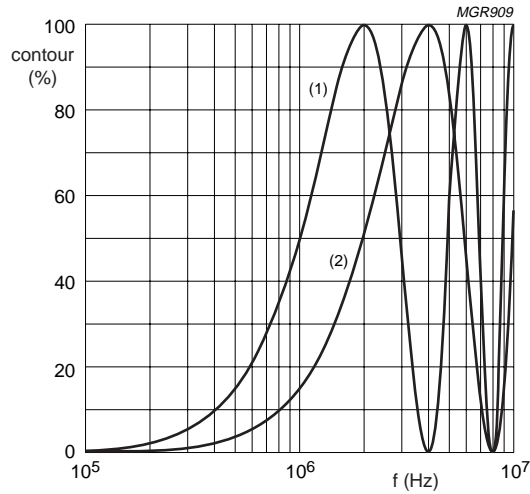
(1) $1f_H$ mode.
(2) $2f_H$ mode.

Fig.15 Frequency transfers of contour filter at f = 2.0 MHz.
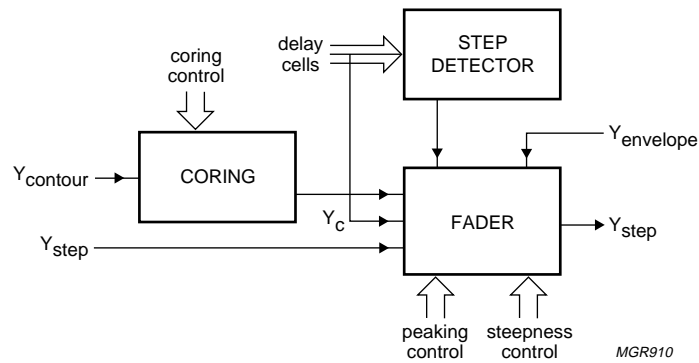
Fig.16 Block diagram of smart sharpness controller.

YUV one chip picture improvement based on luminance
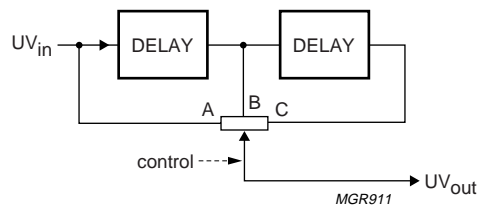vector-, colour vector- and spectral processor   TDA9178

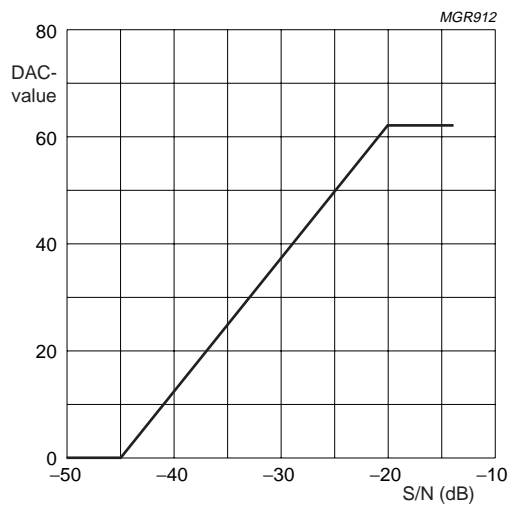Fig.17 Block diagram of colour transient improvement.

Fig.18 Typical noise measurement curve of input noise (dB) versus DAC-value.

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TEST AND APPLICATION INFORMATION

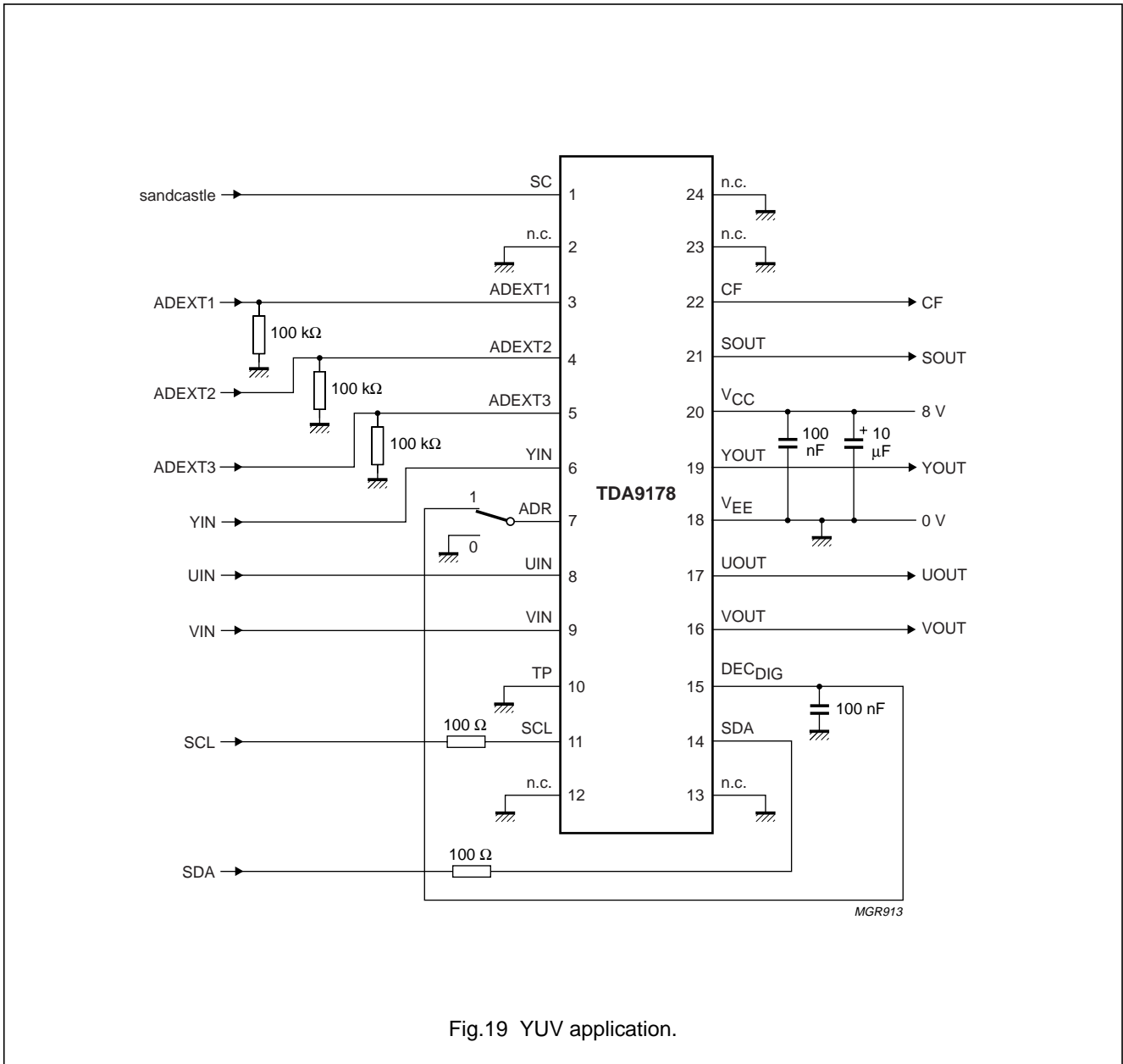The TDA9178 is especially designed for YUV applications. A typical application diagram is shown in Fig.19.
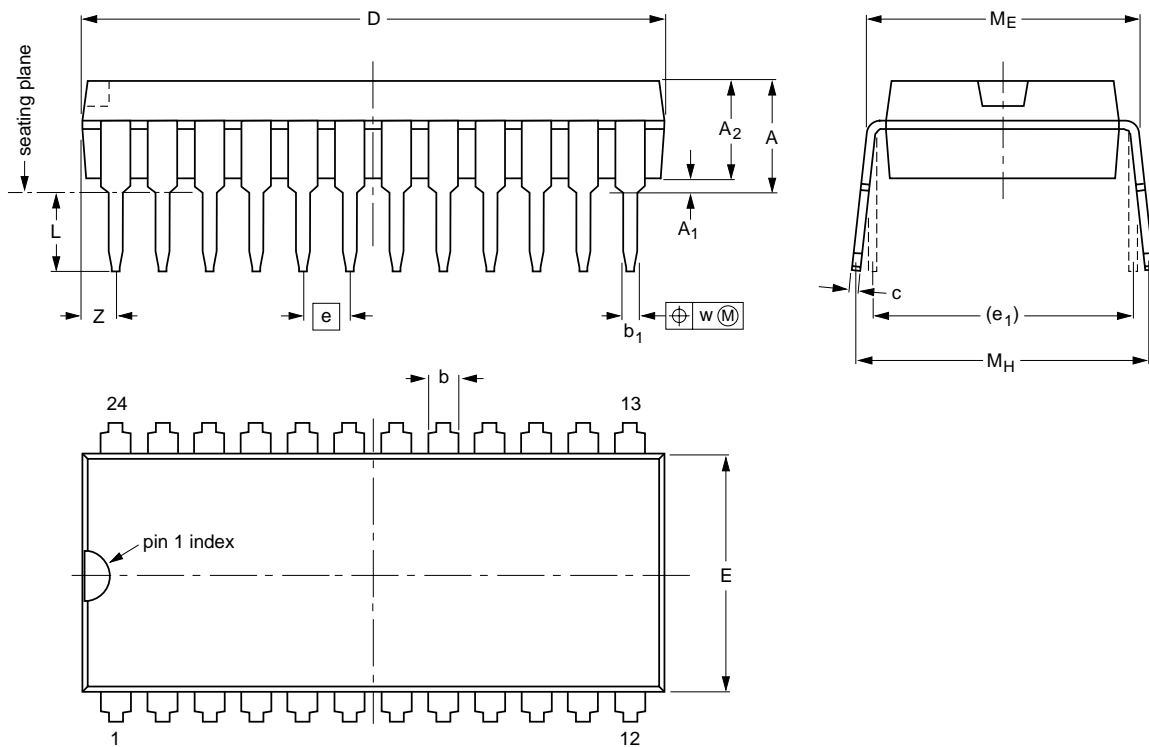

Fig.19 YUV application.

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PACKAGE OUTLINES

SDIP24: plastic shrink dual in-line package; 24 leads (400 mil)

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DIMENSIONS (mm are the original dimensions)

UNIT	A max.	A₁ min.	A₂ max.	b	b₁	c	D (1)	E (1)	e	e₁	L	M_E	M_H	w	Z (1) max.
mm	4.7	0.51	3.8	1.3 0.8	0.53 0.40	0.32 0.23	22.3 21.4	9.1 8.7	1.778	10.16	3.2 2.8	10.7 10.2	12.2 10.5	0.18	1.6

Note

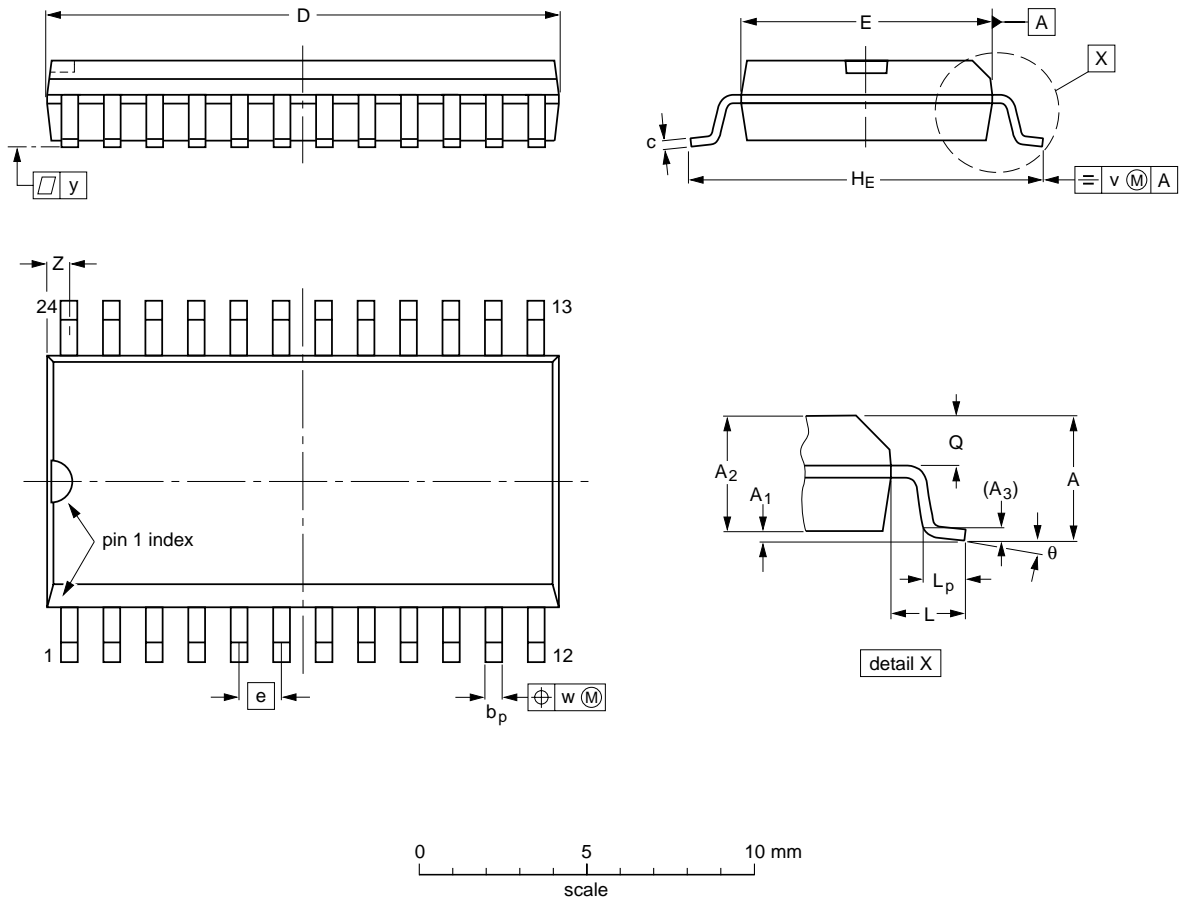1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ			
SOT234-1						~~92-11-17~~ 95-02-04

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SO24: plastic small outline package; 24 leads; body width 7.5 mm   **SOT137-1**

0   5   10 mm

scale

DIMENSIONS (inch dimensions are derived from the original mm dimensions)

UNIT	A max.	A_1	A_2	A_3	b_p	c	$D^{(1)}$	$E^{(1)}$	e	H_E	L	L_p	Q	v	w	y	$Z^{(1)}$	θ
mm	2.65	0.30 0.10	2.45 2.25	0.25	0.49 0.36	0.32 0.23	15.6 15.2	7.6 7.4	1.27	10.65 10.00	1.4	1.1 0.4	1.1 1.0	0.25	0.25	0.1	0.9 0.4	8° 0°
inches	0.10	0.012 0.004	0.096 0.089	0.01	0.019 0.014	0.013 0.009	0.61 0.60	0.30 0.29	0.050	0.419 0.394	0.055	0.043 0.016	0.043 0.039	0.01	0.01	0.004	0.035 0.016	

Note

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ			
SOT137-1	075E05	MS-013AD				~~95-01-24~~ 97-05-22

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SOLDERING

Introduction

This text gives a very brief insight to a complex technology. A more in-depth account of soldering ICs can be found in our *"Data Handbook IC26; Integrated Circuit Packages"* (document order number 9398 652 90011).

There is no soldering method that is ideal for all IC packages. Wave soldering is often preferred when through-hole and surface mount components are mixed on one printed-circuit board. However, wave soldering is not always suitable for surface mount ICs, or for printed-circuit boards with high population densities. In these situations reflow soldering is often used.

Through-hole mount packages

SOLDERING BY DIPPING OR BY SOLDER WAVE

The maximum permissible temperature of the solder is 260 °C; solder at this temperature must not be in contact with the joints for more than 5 seconds. The total contact time of successive solder waves must not exceed 5 seconds.

The device may be mounted up to the seating plane, but the temperature of the plastic body must not exceed the specified maximum storage temperature ($T_{stg(max)}$). If the printed-circuit board has been pre-heated, forced cooling may be necessary immediately after soldering to keep the temperature within the permissible limit.

MANUAL SOLDERING

Apply the soldering iron (24 V or less) to the lead(s) of the package, either below the seating plane or not more than 2 mm above it. If the temperature of the soldering iron bit is less than 300 °C it may remain in contact for up to 10 seconds. If the bit temperature is between 300 and 400 °C, contact may be up to 5 seconds.

Surface mount packages

REFLOW SOLDERING

Reflow soldering requires solder paste (a suspension of fine solder particles, flux and binding agent) to be applied to the printed-circuit board by screen printing, stencilling or pressure-syringe dispensing before package placement.

Several methods exist for reflowing; for example, infrared/convection heating in a conveyor type oven. Throughput times (preheating, soldering and cooling) vary between 100 and 200 seconds depending on heating method.

Typical reflow peak temperatures range from 215 to 250 °C. The top-surface temperature of the packages should preferable be kept below 230 °C.

WAVE SOLDERING

Conventional single wave soldering is not recommended for surface mount devices (SMDs) or printed-circuit boards with a high component density, as solder bridging and non-wetting can present major problems.

To overcome these problems the double-wave soldering method was specifically developed.

If wave soldering is used the following conditions must be observed for optimal results:

- Use a double-wave soldering method comprising a turbulent wave with high upward pressure followed by a smooth laminar wave.
- For packages with leads on two sides and a pitch (e):
  - larger than or equal to 1.27 mm, the footprint longitudinal axis is **preferred** to be parallel to the transport direction of the printed-circuit board;
  - smaller than 1.27 mm, the footprint longitudinal axis **must** be parallel to the transport direction of the printed-circuit board.

  The footprint must incorporate solder thieves at the downstream end.
- For packages with leads on four sides, the footprint must be placed at a 45° angle to the transport direction of the printed-circuit board. The footprint must incorporate solder thieves downstream and at the side corners.

During placement and before soldering, the package must be fixed with a droplet of adhesive. The adhesive can be applied by screen printing, pin transfer or syringe dispensing. The package can be soldered after the adhesive is cured.

Typical dwell time is 4 seconds at 250 °C.
A mildly-activated flux will eliminate the need for removal of corrosive residues in most applications.

MANUAL SOLDERING

Fix the component by first soldering two diagonally-opposite end leads. Use a low voltage (24 V or less) soldering iron applied to the flat part of the lead. Contact time must be limited to 10 seconds at up to 300 °C.

When using a dedicated tool, all other leads can be soldered in one operation within 2 to 5 seconds between 270 and 320 °C.

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Suitability of IC packages for wave, reflow and dipping soldering methods

MOUNTING	PACKAGE	SOLDERING METHOD		
		WAVE	REFLOW[1]	DIPPING
Through-hole mount	DBS, DIP, HDIP, SDIP, SIL	suitable[2]	–	suitable
Surface mount	BGA, LFBGA, SQFP, TFBGA	not suitable	suitable	–
	HBCC, HLQFP, HSQFP, HSOP, HTQFP, HTSSOP, SMS	not suitable[3]	suitable	–
	PLCC[4], SO, SOJ	suitable	suitable	–
	LQFP, QFP, TQFP	not recommended[4][5]	suitable	–
	SSOP, TSSOP, VSO	not recommended[6]	suitable	–

Notes

1. All surface mount (SMD) packages are moisture sensitive. Depending upon the moisture content, the maximum temperature (with respect to time) and body size of the package, there is a risk that internal or external package cracks may occur due to vaporization of the moisture in them (the so called popcorn effect). For details, refer to the *"Data Handbook IC26; Integrated Circuit Packages; Section: Packing Methods"*.

2. For SDIP packages, the longitudinal axis must be parallel to the transport direction of the printed-circuit board.

3. These packages are not suitable for wave soldering as a solder joint between the printed-circuit board and heatsink (at bottom version) can not be achieved, and as solder may stick to the heatsink (on top version).

4. If wave soldering is considered, then the package must be placed at a 45° angle to the solder wave direction. The package footprint must incorporate solder thieves downstream and at the side corners.

5. Wave soldering is only suitable for LQFP, QFP and TQFP packages with a pitch (e) equal to or larger than 0.8 mm; it is definitely not suitable for packages with a pitch (e) equal to or smaller than 0.65 mm.

6. Wave soldering is only suitable for SSOP and TSSOP packages with a pitch (e) equal to or larger than 0.65 mm; it is definitely not suitable for packages with a pitch (e) equal to or smaller than 0.5 mm.

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Data sheet status	
Objective specification	This data sheet contains target or goal specifications for product development.
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.
Product specification	This data sheet contains final product specifications.
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Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.	
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